

# SKM 400GB128D...



**SEMITRANS® 3**

## SPT IGBT Module

**SKM 400GB128D**

**SKM 400GAL128D**

**SKM 400GAR128D**

### Features

- Homogeneous Si
- SPT = Soft-Puch-Through technology
- $V_{CEsat}$  with positive temperature coefficient
- High short circuit capability, self limiting to  $6 \times I_C$

### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders at  $f_{sw}$  up to 20kHz



GB

GAL

GAR

Absolute Maximum Ratings		$T_C = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$	$T_j = 25^\circ\text{C}$	1200		V
$I_C$	$T_j = 150^\circ\text{C}$	$T_C = 25^\circ\text{C}$	565	A
		$T_C = 80^\circ\text{C}$	400	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	600		A
$V_{GES}$		± 20		V
$t_{psc}$	$V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125^\circ\text{C}$ $V_{CES} < 1200\text{ V}$	10		µs
<b>Inverse Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	390	A
		$T_{case} = 80^\circ\text{C}$	260	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	600		A
$I_{FSM}$	$t_p = 10\text{ ms}; \sin.$	$T_j = 150^\circ\text{C}$	2880	A
<b>Freewheeling Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	390	A
		$T_{case} = 80^\circ\text{C}$	260	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	600		A
$I_{FSM}$	$t_p = 10\text{ ms}; \sin$	$T_j = 150^\circ\text{C}$	2880	A
<b>Module</b>				
$I_{t(RMS)}$		500		A
$T_{vj}$		- 40 ... + 150		°C
$T_{stg}$		- 40 ... + 125		°C
$V_{isol}$	AC, 1 min.	4000		V

Characteristics		$T_C = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 12\text{ mA}$	4,5	5,5	6,45	V
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$		0,2	0,6	mA
$V_{CE0}$		$T_j = 25^\circ\text{C}$	1	1,15	V
		$T_j = 125^\circ\text{C}$	0,9	1,05	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	3	4	mΩ
		$T_j = 125^\circ\text{C}$	4	5	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 300\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	1,9	2,35	V
		$T_j = 125^\circ\text{C}_{chiplev.}$	2,1	2,55	V
$C_{ies}$	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	26		nF
$C_{oes}$			3		nF
$C_{res}$			3		nF
$Q_G$	$V_{GE} = -8\text{ V} - +20\text{ V}$	3700		nC	
$R_{Gint}$	$T_j = 25^\circ\text{C}$	1,25		Ω	
$t_{d(on)}$	$R_{Gon} = 4,7\ \Omega$	$V_{CC} = 600\text{ V}$ $I_C = 300\text{ A}$	110		ns
$t_r$			60		ns
$E_{on}$	$R_{Goff} = 4,7\ \Omega$	$T_j = 125^\circ\text{C}$ $V_{GE} = \pm 15\text{ V}$	32		mJ
$t_{d(off)}$			800		ns
$t_f$			60		ns
$E_{off}$			31		mJ
$R_{th(j-c)}$	per IGBT			0,055	K/W



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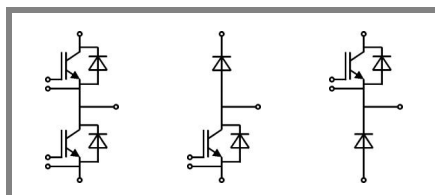
**SKM 400GAR128D**

### Features

- Homogeneous Si
- SPT = Soft-Puch-Through technology
- $V_{CEsat}$  with positive temperature coefficient
- High short circuit capability, self limiting to  $6 \times I_c$

### Typical Applications\*

- AC inverter drives
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Characteristics		min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 300 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	3	4,3	mΩ
$I_{RRM}$	$I_F = 300 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	176		A
$Q_{rr}$	$di/dt = 2400 \text{ A}/\mu\text{s}$		40		μC
$E_{rr}$	$V_{GE} = -15 \text{ V}; V_{CC} = 600 \text{ V}$		16		mJ
$R_{th(j-c)D}$	per diode			0,125	K/W
<b>FWD</b>					
$V_F = V_{EC}$	$I_{Fnom} = 300 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	3	4,3	V
$I_{RRM}$	$I_F = 300 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	176		A
$Q_{rr}$	$di/dt = 2400 \text{ A}/\mu\text{s}$		40		μC
$E_{rr}$	$V_{GE} = -15 \text{ V}; V_{CC} = 600 \text{ V}$		16		mJ
$R_{th(j-c)D}$	per diode			0,125	K/W
<b>Module</b>					
$L_{CE}$			15	20	nH
$R_{CC+EE'}$	res., terminal-chip	$T_{case} = 25 \text{ }^\circ\text{C}$	0,35		mΩ
		$T_{case} = 125 \text{ }^\circ\text{C}$	0,5		mΩ
$R_{th(c-s)}$	per module			0,038	K/W
$M_s$	to heat sink M6		3	5	Nm
$M_t$	to terminals M6		2,5	5	Nm
w				325	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.



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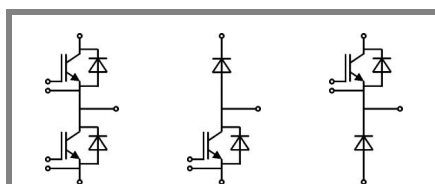
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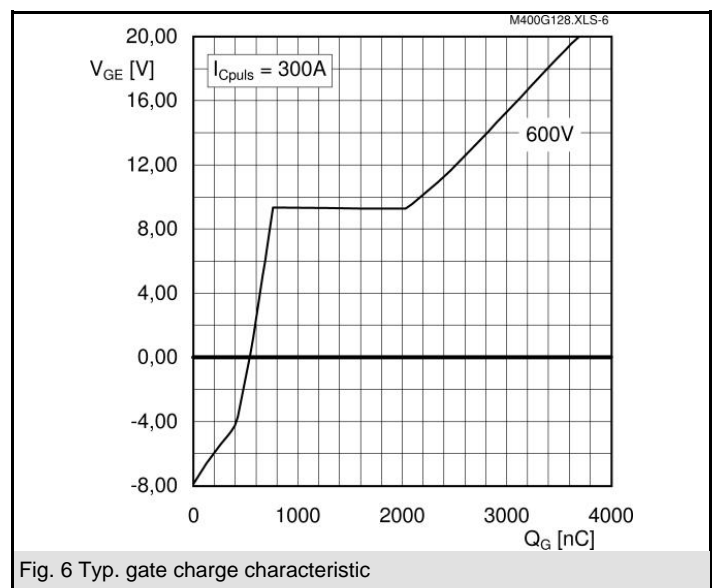
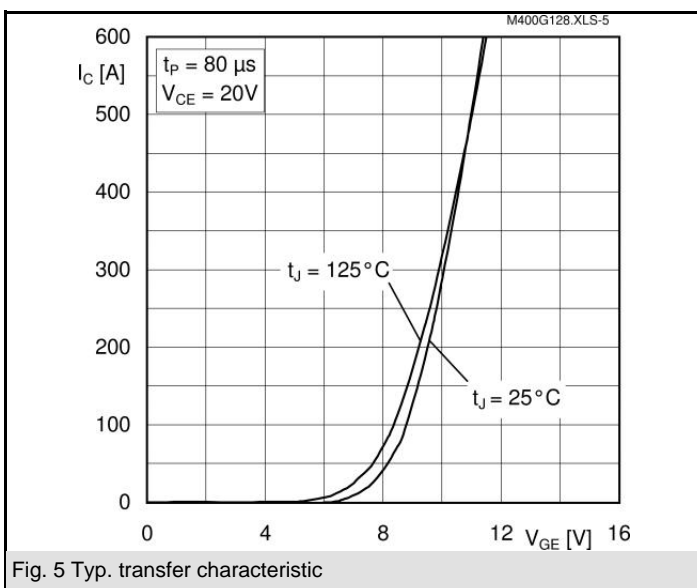
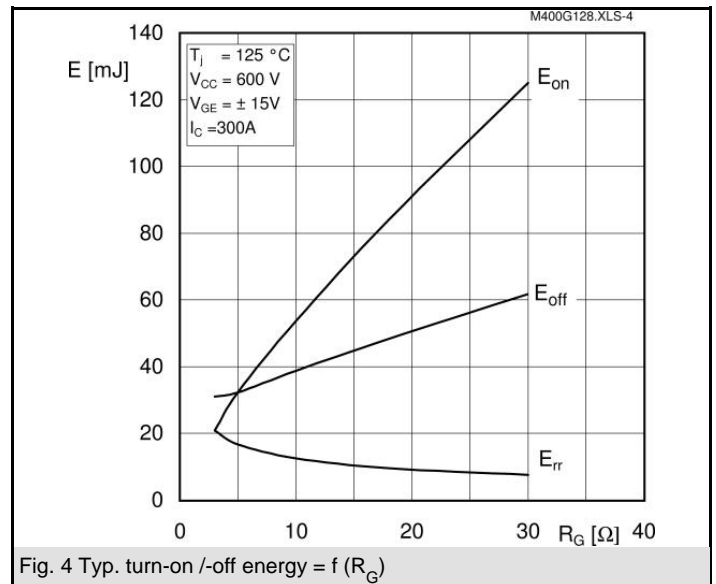
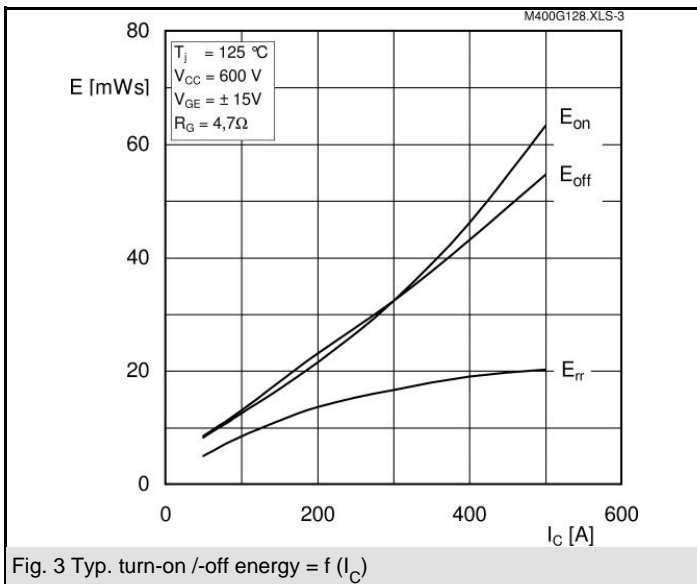
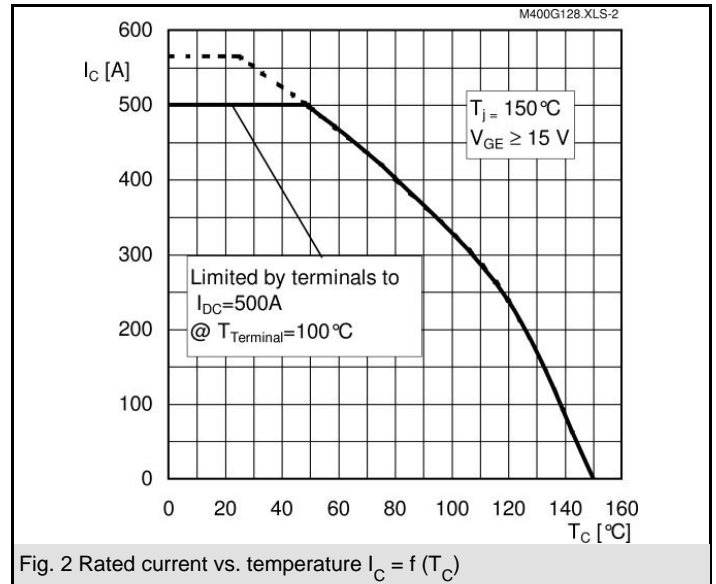
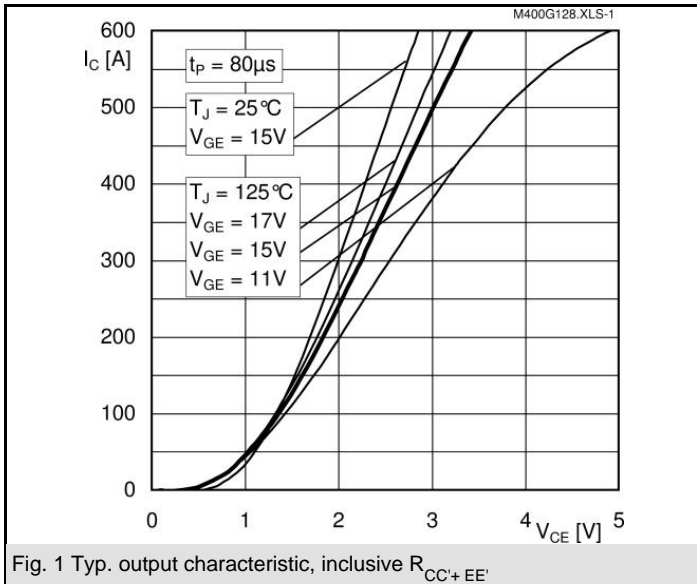
$Z_{th}$		Conditions	Values	Units
<b><math>Z_{th(j-c)I}</math></b>				
$R_{\theta j-c}$	$i = 1$		37	mk/W
$R_{\theta j-c}$	$i = 2$		14	mk/W
$R_{\theta j-c}$	$i = 3$		3,45	mk/W
$R_{\theta j-c}$	$i = 4$		0,55	mk/W
$\tau_{th(j-c)}$	$i = 1$		0,0744	s
$\tau_{th(j-c)}$	$i = 2$		0,0078	s
$\tau_{th(j-c)}$	$i = 3$		0,0024	s
$\tau_{th(j-c)}$	$i = 4$		0,0002	s
<b><math>Z_{th(j-c)D}</math></b>				
$R_{\theta j-c}$	$i = 1$		75	mk/W
$R_{\theta j-c}$	$i = 2$		38	mk/W
$R_{\theta j-c}$	$i = 3$		10,6	mk/W
$R_{\theta j-c}$	$i = 4$		1,4	mk/W
$\tau_{th(j-c)}$	$i = 1$		0,0386	s
$\tau_{th(j-c)}$	$i = 2$		0,0201	s
$\tau_{th(j-c)}$	$i = 3$		0,001	s
$\tau_{th(j-c)}$	$i = 4$		0,003	s

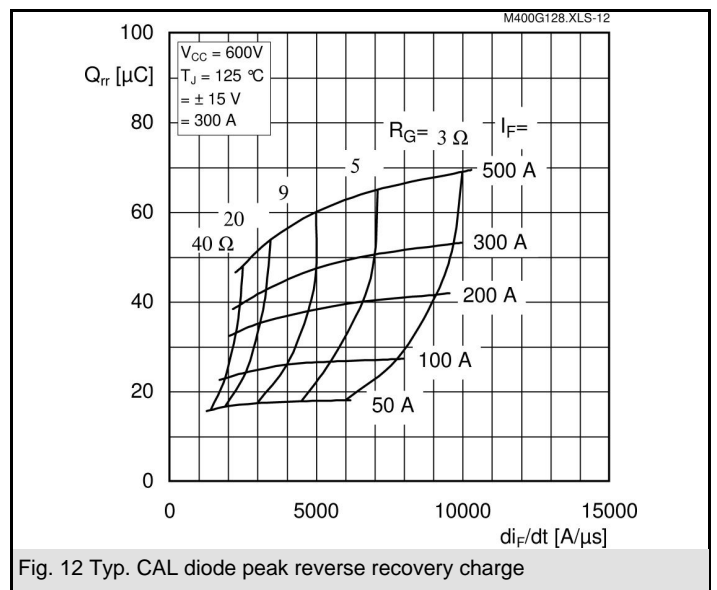
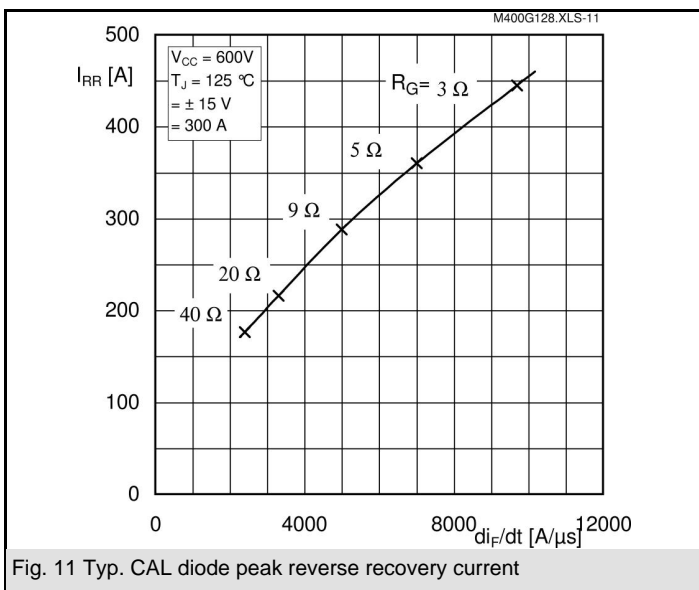
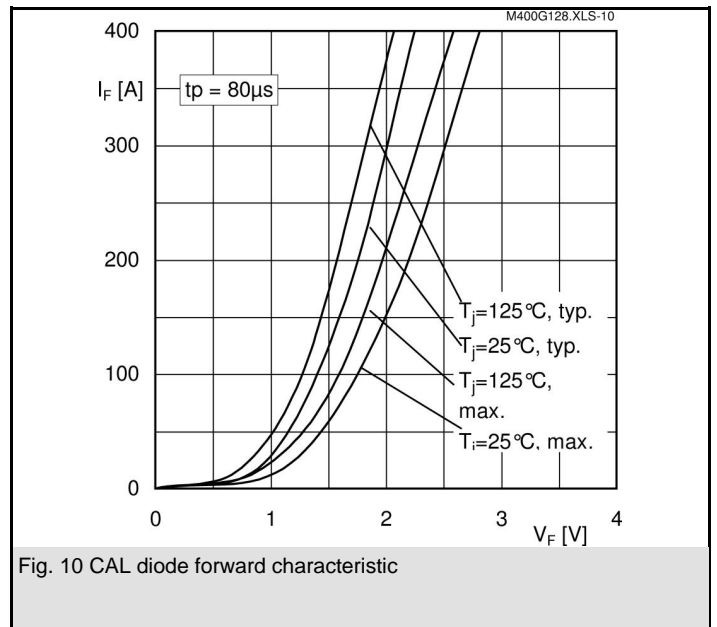
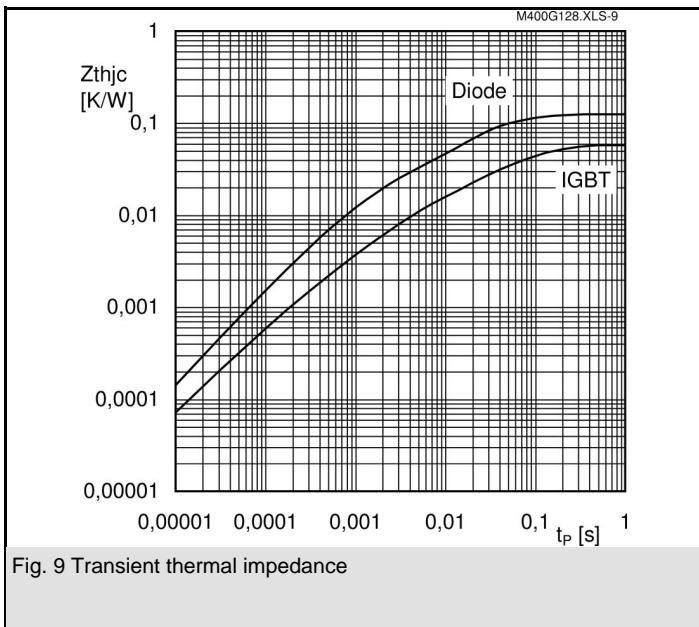
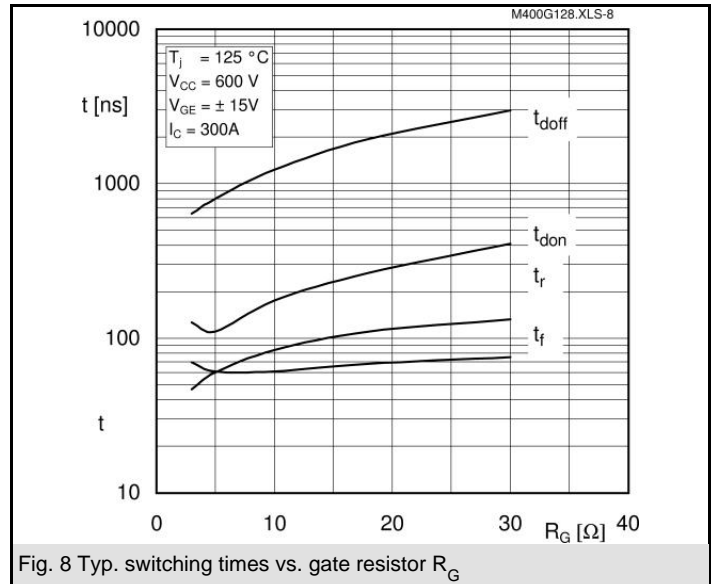
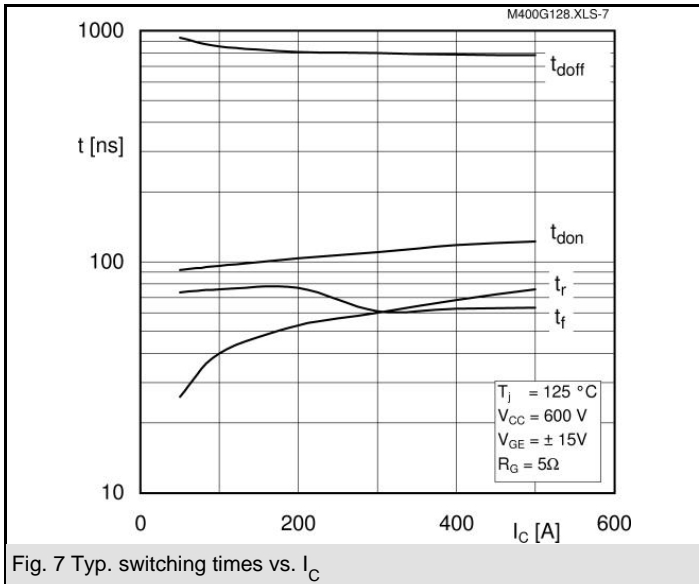


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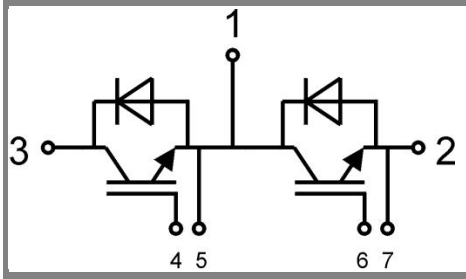
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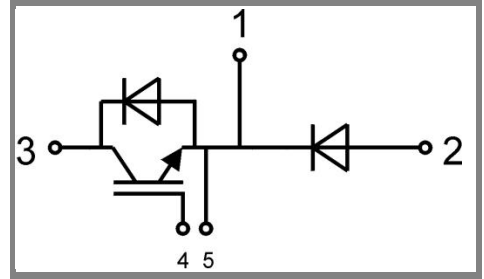
Case D 56



GB Case D 56



GAL Case D 57



GAR Case D 58